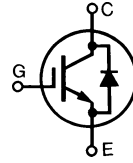




Low $V_{CE(sat)}$ IGBT with Diode
High Speed IGBT with Diode
 Combi Pack

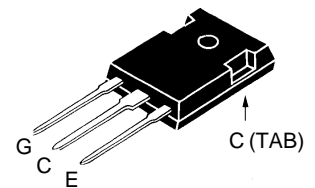
IXGH 12N100U1
IXGH 12N100AU1

| V_{CES} | I_{C25} | $V_{CE(sat)}$ |
|-----------|-----------|---------------|
| 1000 V | 24 A | 3.5 V |
| 1000 V | 24 A | 4.0 V |



| Symbol | Test Conditions | Maximum Ratings | |
|-------------------------------|---|-----------------------------------|------------------|
| V_{CES} | $T_J = 25^\circ\text{C}$ to 150°C | 1000 | V |
| V_{CGR} | $T_J = 25^\circ\text{C}$ to 150°C ; $R_{GE} = 1\text{ M}\Omega$ | 1000 | V |
| V_{GES} | Continuous | ± 20 | V |
| V_{GEM} | Transient | ± 30 | V |
| I_{C25} | $T_C = 25^\circ\text{C}$ | 24 | A |
| I_{C90} | $T_C = 90^\circ\text{C}$ | 12 | A |
| I_{CM} | $T_C = 25^\circ\text{C}$, 1 ms | 48 | A |
| SSOA (RBSOA) | $V_{GE} = 15\text{ V}$, $T_{VJ} = 125^\circ\text{C}$, $R_G = 150\ \Omega$ Clamped inductive load, $L = 300\ \mu\text{H}$ | $I_{CM} = 24$ @ $0.8\ V_{CES}$ | A |
| P_C | $T_C = 25^\circ\text{C}$ | 100 | W |
| T_J | | -55 ... +150 | $^\circ\text{C}$ |
| T_{JM} | | 150 | $^\circ\text{C}$ |
| T_{stg} | | -55 ... +150 | $^\circ\text{C}$ |
| M_d | Mounting torque with screw M3 | 1.13/10 | Nm/lb.in. |
| Weight | | 6 | g |
| | Maximum lead temperature for soldering 1.6 mm (0.062 in.) from case for 10 s | 300 | $^\circ\text{C}$ |

TO-247AD



G = Gate C = Collector
 E = Emitter TAB = Collector

Features

- International standard packages JEDEC TO-247
- IGBT with antiparallel FRED in one package
- HDMOS™ process
- Low $V_{CE(sat)}$
 - for minimum on-state conduction losses
- MOS Gate turn-on
 - drive simplicity
- Fast Recovery Exptial Diode (FRED)
 - soft recovery with low I_{RM}

Applications

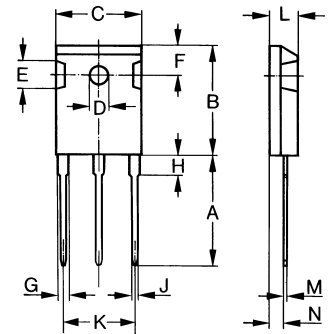
- DC choppers
- AC motor speed control
- DC servo and robot drives
- Uninterruptible power supplies (UPS)
- Switch-mode and resonant-mode power supplies

Advantages

- Easy to mount with one screw
- Reduces assembly time and cost
- Space savings (two devices in one package)

| Symbol | Test Conditions ($T_J = 25^\circ\text{C}$, unless otherwise specified) | Characteristic Values | | |
|---------------|--|-----------------------|--------|-------------------------------------|
| | | Min. | Typ. | Max. |
| BV_{CES} | $I_C = 3\text{ mA}$, $V_{GE} = 0\text{ V}$ BV_{CES} temperature coefficient | 1000 | 0.072 | V %/K |
| $V_{GE(th)}$ | $I_C = 500\ \mu\text{A}$, $V_{GE} = V_{GE}$ $V_{GE(th)}$ temperature coefficient | 2.5 | -0.192 | V %/K |
| I_{CES} | $V_{CE} = 0.8$, V_{CES} $T_J = 25^\circ\text{C}$ $V_{GE} = 0\text{ V}$ $T_J = 125^\circ\text{C}$ | | | 300 μA 5 mA |
| I_{GES} | $V_{CE} = 0\text{ V}$, $V_{GE} = \pm 20\text{ V}$ | | | ± 100 nA |
| $V_{CE(sat)}$ | $I_C = I_{CE90}$, $V_{GE} = 15$ | | | 12N100U1: 3.5 V 12N100AU1: 4.0 V |

| Symbol | Test Conditions ($T_J = 25^\circ\text{C}$, unless otherwise specified) | Characteristic Values | | |
|--------------|---|-----------------------|------|----------|
| | | Min. | Typ. | Max. |
| g_{fs} | $I_C = I_{C90}$; $V_{CE} = 10\text{ V}$, Pulse test, $t \leq 300\ \mu\text{s}$, duty cycle $\leq 2\%$ | 6 | 10 | S |
| C_{ies} | $V_{CE} = 25\text{ V}$, $V_{GE} = 0\text{ V}$, $f = 1\text{ MHz}$ | | 750 | pF |
| C_{oes} | | | 120 | pF |
| C_{res} | | | 30 | pF |
| Q_g | $I_C = I_{C90}$, $V_{GE} = 15\text{ V}$, $V_{CE} = 0.5 V_{CES}$ | | 65 | 90 nC |
| Q_{ge} | | | 8 | 20 nC |
| Q_{gc} | | | 24 | 45 nC |
| $t_{d(on)}$ | Inductive load, $T_J = 25^\circ\text{C}$ $I_C = I_{C90}$, $V_{GE} = 15\text{ V}$, $L = 300\ \mu\text{H}$ $V_{CE} = 800\text{ V}$, $R_G = R_{off} = 120\ \Omega$ Remarks: Switching times may increase for V_{CE} (Clamp) $> 0.8 V_{CES}$, higher T_J or increased R_G | | 100 | ns |
| t_{ri} | | | 200 | ns |
| $t_{d(off)}$ | | | 850 | 1000 ns |
| t_{fi} | | 12N100U1 | 800 | 1000 ns |
| | | 12N100AU1 | 500 | 700 ns |
| E_{off} | | 12N100U1 | 2.5 | mJ |
| | | 12N100AU1 | 1.5 | 3.0 mJ |
| $t_{d(on)}$ | Inductive load, $T_J = 125^\circ\text{C}$ $I_C = I_{C90}$, $V_{GE} = 15\text{ V}$, $L = 300\ \mu\text{H}$ $V_{CE} = 800\text{ V}$, $R_G = R_{off} = 120\ \Omega$ Remarks: Switching times may increase for V_{CE} (Clamp) $> 0.8 V_{CES}$, higher T_J or increased R_G | | 100 | ns |
| t_{ri} | | | 200 | ns |
| $E_{(on)}$ | | | 1.1 | mJ |
| $t_{d(off)}$ | | 12N100U1 | 900 | ns |
| t_{fi} | | 12N100AU1 | 1250 | ns |
| E_{off} | | 12N100U1 | 950 | ns |
| | | 12N100U1 | 3.5 | mJ |
| | | 12N100AU1 | 2.2 | mJ |
| R_{thJC} | | | | 1.25 K/W |
| R_{thCK} | | | 0.25 | K/W |

TO-247 AD (IXGH) Outline


| Dim. | Millimeter | | Inches | |
|------|------------|-------|--------|-------|
| | Min. | Max. | Min. | Max. |
| A | 19.81 | 20.32 | 0.780 | 0.800 |
| B | 20.80 | 21.46 | 0.819 | 0.845 |
| C | 15.75 | 16.26 | 0.610 | 0.640 |
| D | 3.55 | 3.65 | 0.140 | 0.144 |
| E | 4.32 | 5.49 | 0.170 | 0.216 |
| F | 5.4 | 6.2 | 0.212 | 0.244 |
| G | 1.65 | 2.13 | 0.065 | 0.084 |
| H | - | 4.5 | - | 0.177 |
| J | 1.0 | 1.4 | 0.040 | 0.055 |
| K | 10.8 | 11.0 | 0.426 | 0.433 |
| L | 4.7 | 5.3 | 0.185 | 0.209 |
| M | 0.4 | 0.8 | 0.016 | 0.031 |
| N | 1.5 | 2.49 | 0.087 | 0.102 |

| Symbol | Test Conditions ($T_J = 25^\circ\text{C}$, unless otherwise specified) | Characteristic Values | | |
|------------|---|---------------------------|------|---------|
| | | Min. | Typ. | Max. |
| V_F | $I_F = 8\text{ A}$, $V_{GE} = 0\text{ V}$, Pulse test, $t \leq 300\ \mu\text{s}$, duty cycle $d \leq 2\%$ | | | 2.75 V |
| I_{RM} | $I_F = I_{C90}$, $V_{GE} = 0\text{ V}$, $-di_F/dt = 100\text{ A}/\mu\text{s}$ | | 6.5 | A |
| t_{rr} | $V_R = 540\text{ V}$ | $T_J = 125^\circ\text{C}$ | 120 | ns |
| | $I_F = 1\text{ A}$, $-di_F/dt = 50\text{ A}/\mu\text{s}$, $V_R = 30\text{ V}$ | $T_J = 25^\circ\text{C}$ | 50 | 60 ns |
| R_{thJC} | | | | 2.5 K/W |

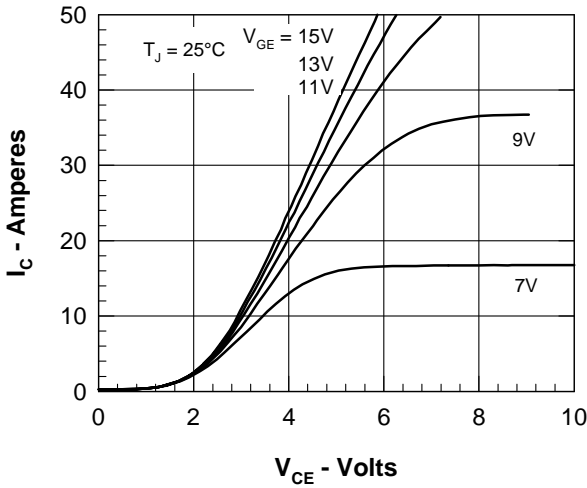


Figure 1. Saturation Voltage Characteristics

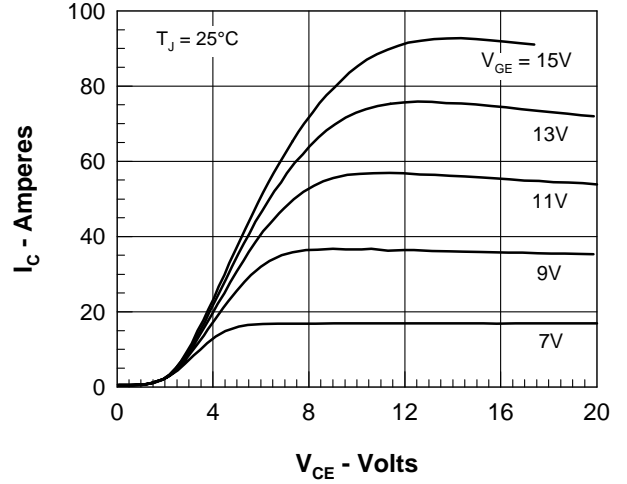


Figure 2. Extended Output Characteristics

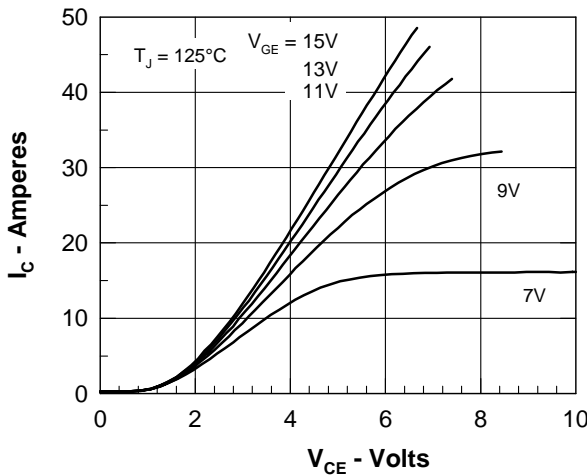


Figure 3. Saturation Voltage Characteristics

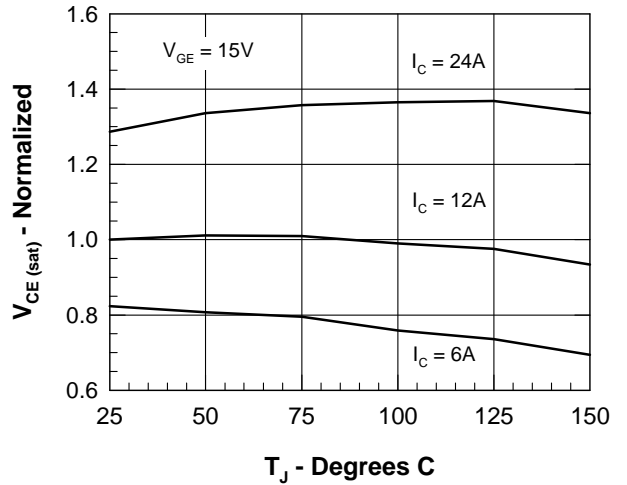


Figure 4. Temperature Dependence of $V_{CE(sat)}$

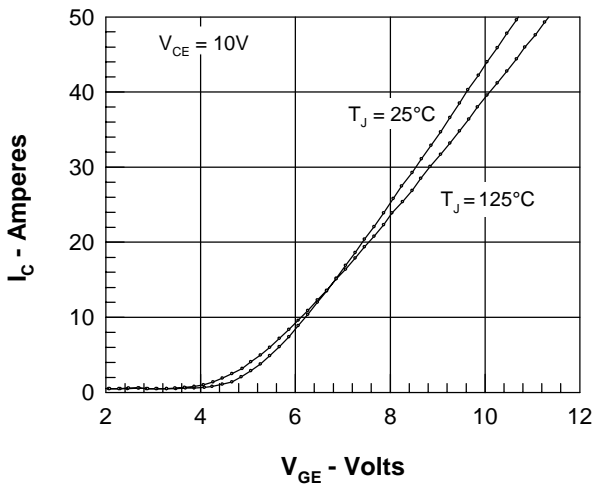


Figure 5. Admittance Curves

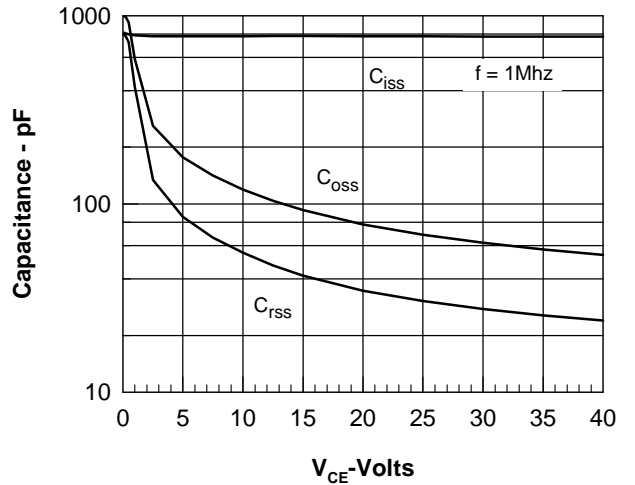


Figure 6. Capacitance Curves

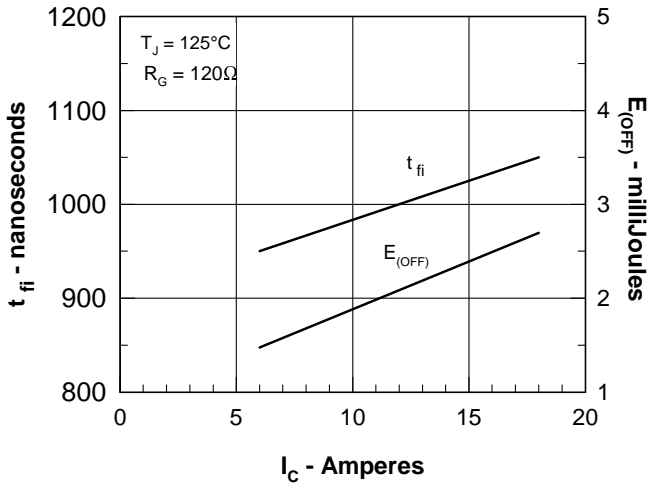


Figure 7. Dependence of t_{fi} and E_{OFF} on I_C .

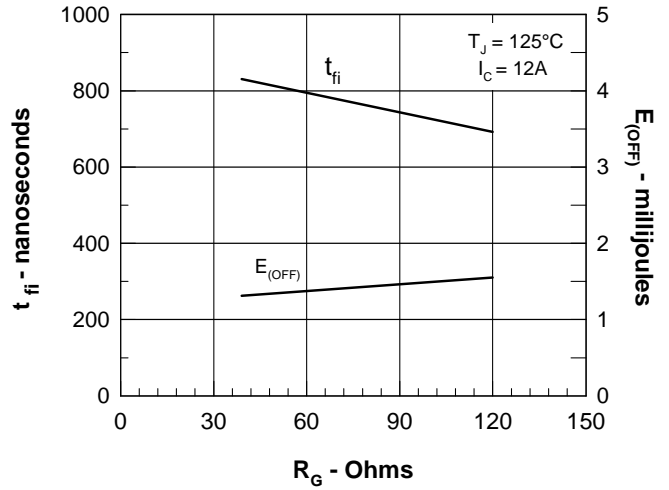


Figure 8. Dependence of t_{fi} and E_{OFF} on R_G .

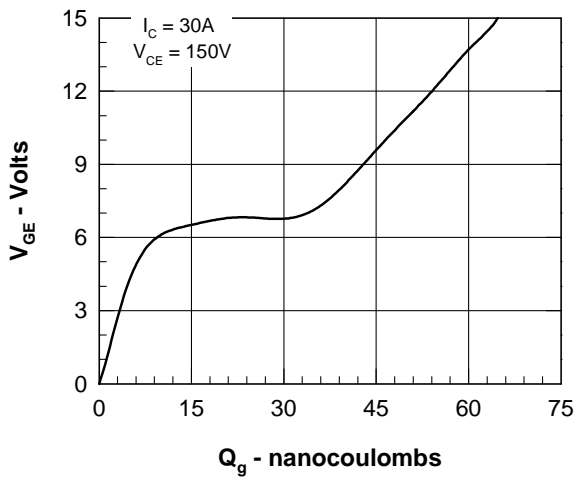


Figure 9. Gate Charge

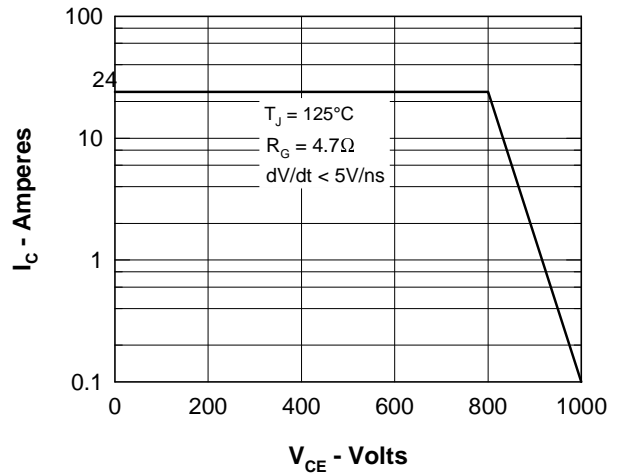


Figure 10. Turn-off Safe Operating Area

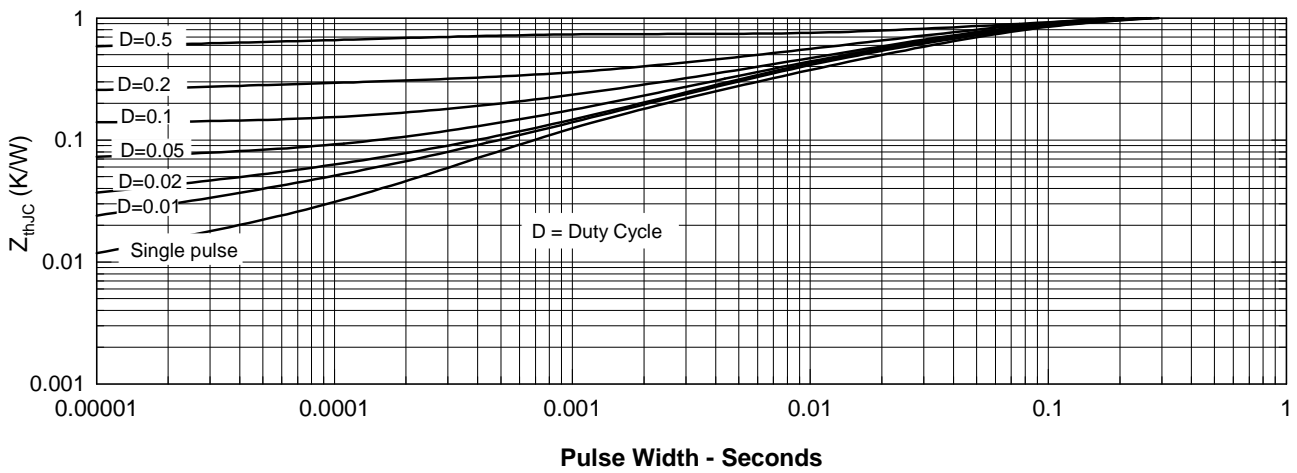


Figure 11. Transient Thermal Resistance

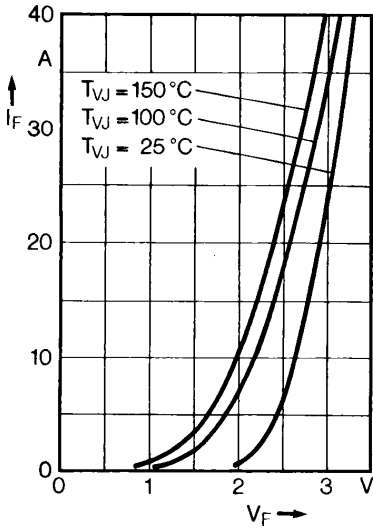


Fig. 12. Forward current versus voltage drop.

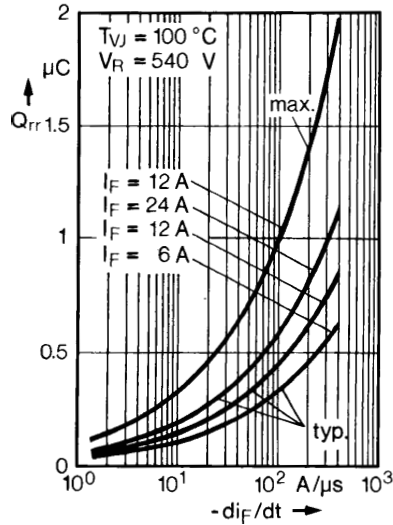


Fig. 13. Recovery charge versus $-di_F/dt$.

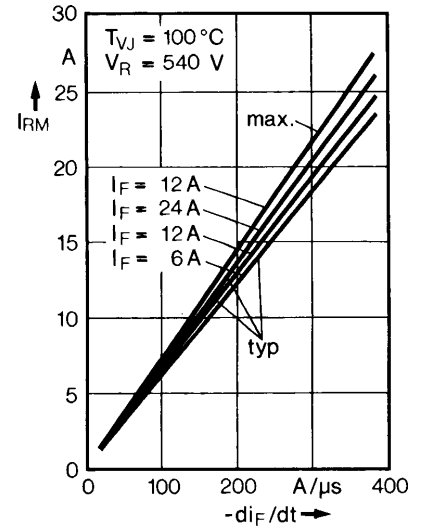


Fig. 14. Peak reverse current versus $-di_F/dt$.

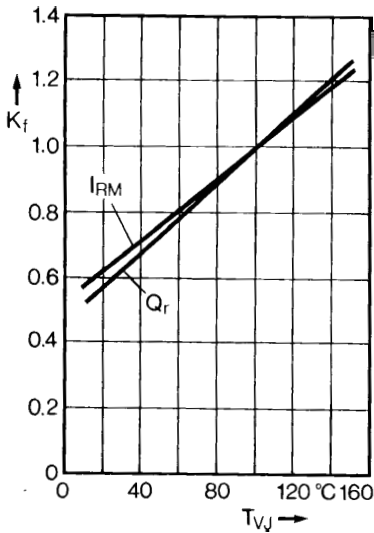


Fig. 15. Dynamic parameters versus junction temperature.

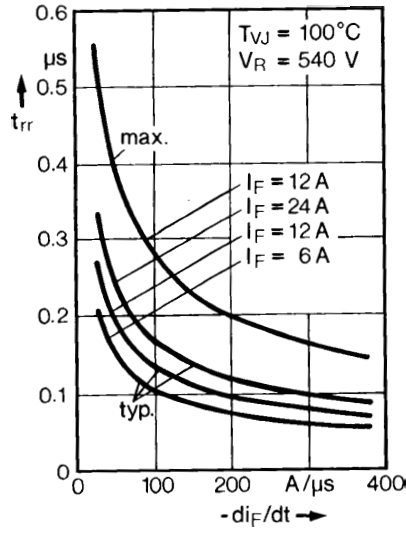


Fig. 16. Reverse recovery time versus $-di_F/dt$.

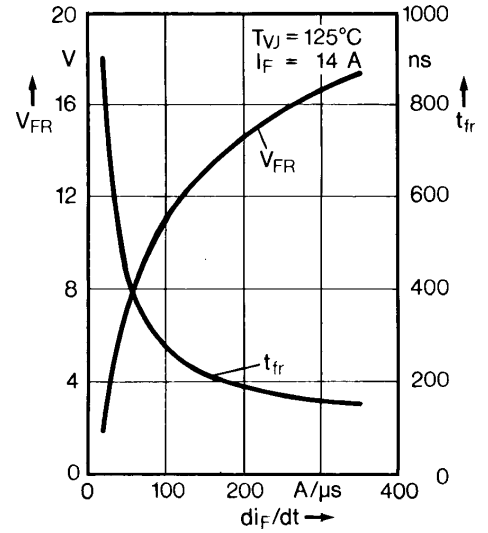


Fig. 17. Forward voltage recovery and time versus $-di_F/dt$.

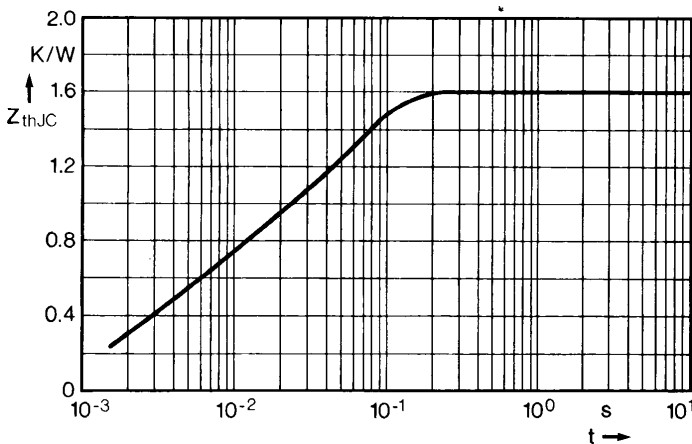


Fig. 18. Transient thermal impedance junction to case.